

Notice of References Cited

Application/Control No.
09/838,743

Applicant(s)/Patent Under
Reexamination
DEBOY ET AL.

Examiner
Johannes P Mondt

Art Unit
2826

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,387,528	02-1995	Hutchings et al	437/40
	B	US-5,702,961	12-1997	Park	437/40
	C	US-6,011,280	01-2000	Fruth et al.	257/137
	D	US-4,901,127	02-1990	Chow et al.	357/23.4
	E	US-4,636,830	01-1987	Bhagat	357/38
	F	US-5,973,338	10-1999	Okabe et al.	257/133
	G	US-5,821,586	10-1998	Yamaguchi et al.	257/355
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP404234173A	08-1992	Japan	Yamamoto	H01L029/784
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Laska et al, "A 2000 V-Non-Punch-Through-IGBT with Dynamical Properties like a 1000 V-IGBT", Int. Electron Dev. Mtg., New York, IEEE, 1990 (pages 807-810) (IDS, hence not provided herewith)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.